

| | | | | |
|-----------------------------------|--|-------------------------|---|-------------|
| Notice of References Cited | | Application/Control No. | Applicant(s)/Patent Under Reexamination | |
| | | 10/632,411 | SUBRAHMANYA, PARVATHANATH | |
| Examiner | | Art Unit | | Page 1 of 1 |
| Kiet Doan | | 2683 | | |

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|--|-----------------|------------------|----------------|
| | A | US-6,236,365 B1 | 05-2001 | LeBlanc et al. | 342/457 |
| | B | US-2001/0000219 | 04-2001 | Agazzi et al. | 375/230 |
| | C | US-2001/0004384 | 06-2001 | Takanashi et al. | 375/229 |
| | D | US-6,658,050 B1 | 12-2003 | Ramesh et al. | 375/219 |
| | E | US-6,151,358 A | 11-2000 | Lee et al. | 375/232 |
| | F | US-6,301,291 B1 | 10-2001 | Rouphael et al. | 375/150 |
| | G | US-5,267,266 A | 11-1993 | Chen, Walter Y. | 375/232 |
| | H | US-2002/0042279 A1 | 04-2002 | Da Rocha et al. | 455/456 |
| | I | US- | | | |
| | J | US- | | | |
| | K | US- | | | |
| | L | US- | | | |
| | M | US- | | | |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
|---|---|--|-----------------|---------|------|----------------|
| | N | | | | | |
| | O | | | | | |
| | P | | | | | |
| | Q | | | | | |
| | R | | | | | |
| | S | | | | | |
| | T | | | | | |

NON-PATENT DOCUMENTS

| | | |
|---|---|---|
| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) |
| | U | |
| | V | |
| | W | |
| | X | |

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.